

<b>Notice of References Cited</b>	Application/Control No. 10/579,048		Applicant(s)/Patent Under Reexamination YEUNG ET AL.	
	Examiner VINH LAM		Art Unit 2629	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,404,458 A	04-1995	Zetts, John M.	710/73
*	B	US-5,739,814 A	04-1998	Ohara et al.	345/173
*	C	US-6,040,825 A	03-2000	Yamamoto et al.	345/173
*	D	US-6,191,777 B1	02-2001	Yasuhara et al.	345/173
*	E	US-6,297,812 B1	10-2001	Ohara et al.	345/173
*	F	US-2002/0041271 A1	04-2002	LeKuch et al.	345/173
*	G	US-7,081,885 B2	07-2006	Blume, Leo	345/173
*	H	US-7,091,960 B1	08-2006	Silverbrook et al.	345/173
*	I	US-7,106,309 B2	09-2006	Wood et al.	345/173
*	J	US-7,283,129 B1	10-2007	Sawada et al.	345/204
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.